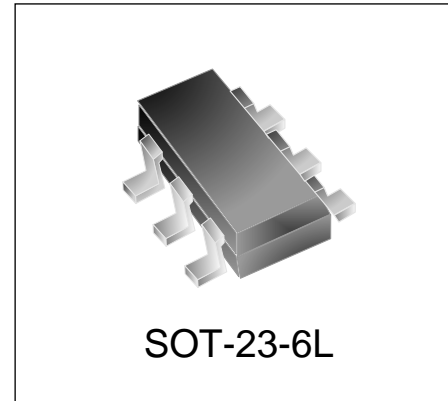


Features

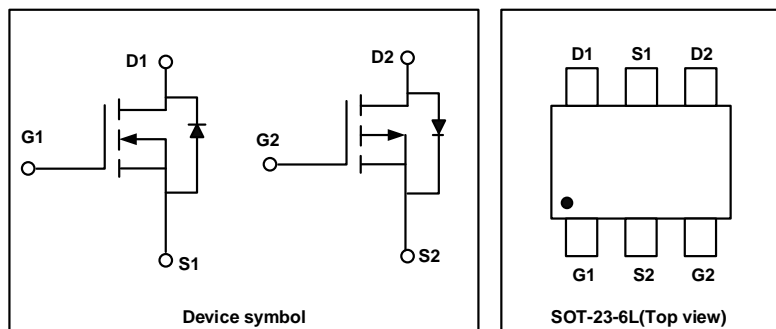
- Way-on Small Signal MOSFETs
- N-Channel:
 - $V_{DS} = 20V, I_D = 5A$
 - $R_{DS(on)} < 34m\Omega @ V_{GS} = 4.5V$
 - $R_{DS(on)} < 50m\Omega @ V_{GS} = 2.5V$
- P-Channel:
 - $V_{DS} = -20V, I_D = -3A$
 - $R_{DS(on)} < 70m\Omega @ V_{GS} = -4.5V$
 - $R_{DS(on)} < 90m\Omega @ V_{GS} = -2.5V$
- Trench LV MOSFET Technology



Mechanical Characteristics

- SOT-23-6L Package
- Marking : Making Code
- RoHS Compliant

Schematic & PIN Configuration



Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter		Symbol	Value		Unit
Drain-Source voltage		V_{DS}	20	-20	V
Gate-Source voltage		V_{GS}	± 8	± 8	
Continuous Drain Current	$T_A=25^\circ C$	I_D	5	-3	A
Pulsed Drain Current ¹		I_{DM}	20	-12	A
Power Dissipation ¹	$T_A=25^\circ C$	P_D	1		W
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150		$^\circ C$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Ambient ²	$R_{\theta JA}$	125	$^\circ C/W$

Electrical Characteristics N-Channel ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	20	-	-	V
Gate-body Leakage current	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 8V$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20V, V_{GS} = 0V$	-	-	1	μA
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.5	0.65	1	V
Static Drain-Source On-Resistance ³	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 4.5A$	-	25	34	m Ω
		$V_{GS} = 2.5V, I_D = 3.5A$	-	35	50	
Dynamic characteristics⁴						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 10V,$ $f = 1MHz$	-	300	-	pF
Output Capacitance	C_{oss}		-	55	-	
Reverse Transfer Capacitance	C_{rss}		-	48	-	
Switching Characteristics⁴						
Total Gate Charge	Q_g	$V_{GS} = 4.5V, V_{DS} = 10V,$ $I_D = 4.5A$	-	3.6	-	nC
Gate-Source Charge	Q_{gs}		-	0.6	-	
Gate-Drain Charge	Q_{gd}		-	0.7	-	
Turn-on Delay Time	$t_{d(on)}$	$V_{GS} = 4.5V, V_{DD} = 10V,$ $I_D = 4.5A, R_G = 3\Omega$	-	3.1	-	ns
Rise Time	t_r		-	4.6	-	
Turn-off Delay Time	$t_{d(off)}$		-	11.7	-	
Fall Time	t_f		-	3.5	-	
Drain-Source Body Diode Characteristics						
Body Diode Voltage ³	V_{SD}	$I_S = 1A, V_{GS} = 0V$	-	-	1.2	V
Continuous Source Current	I_S		-	-	5	A

Electrical Characteristics P-Channel ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-20	-	-	V
Gate-body Leakage current	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 8V$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -20V, V_{GS} = 0V$	-	-	-1	μA
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.5	-0.7	-1	V
Static Drain-Source On-Resistance ³	$R_{DS(on)}$	$V_{GS} = -4.5V, I_D = -3A$	-	45	70	m Ω
		$V_{GS} = -2.5V, I_D = -1.5A$	-	58	90	
Dynamic characteristics⁴						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = -10V,$ $f = 1MHz$	-	502	-	pF
Output Capacitance	C_{oss}		-	69	-	
Reverse Transfer Capacitance	C_{rss}		-	58	-	
Switching Characteristics⁴						
Total Gate Charge	Q_g	$V_{GS} = -4.5V, V_{DS} = -10V,$ $I_D = -3A$	-	6.2	-	nC
Gate-Source Charge	Q_{gs}		-	0.5	-	
Gate-Drain Charge	Q_{gd}		-	1.3	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = -4.5V, V_{DD} = -10V,$ $I_D = -3A, R_G = 3\Omega$	-	11	-	ns
Rise Time	t_r		-	17.5	-	
Turn-Off Delay Time	$t_{d(off)}$		-	23	-	
Fall Time ⁴	t_f		-	10	-	
Drain-Source Body Diode Characteristics						
Body Diode Voltage ³	V_{SD}	$I_S = -3A, V_{GS} = 0V$	-	-	-1.2	V
Continuous Source Current	I_S		-	-	-3	A

Notes:

1. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^{\circ}\text{C}$.
2. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
3. Pulse Test: Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
4. This value is guaranteed by design hence it is not included in the production test.

Typical Characteristics:N-CHANNEL

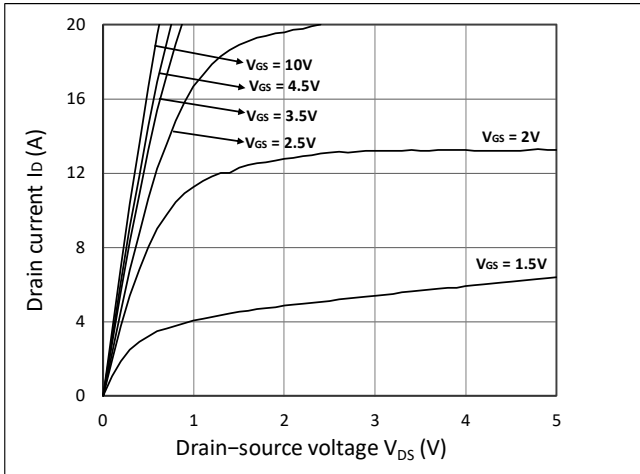


Figure 1. Output Characteristics

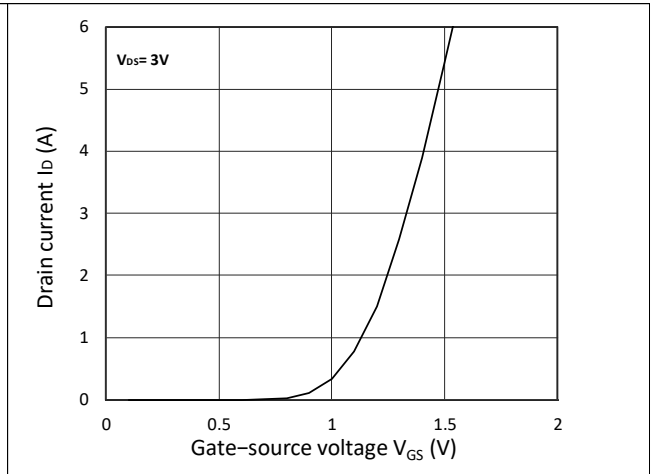


Figure 2. Transfer Characteristics

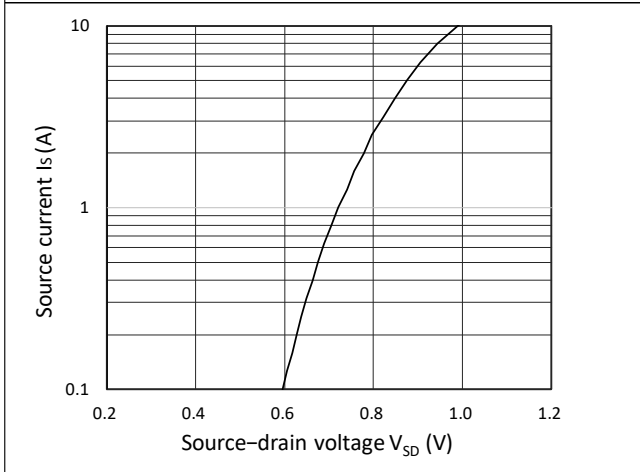


Figure 3. Forward Characteristics of Reverse

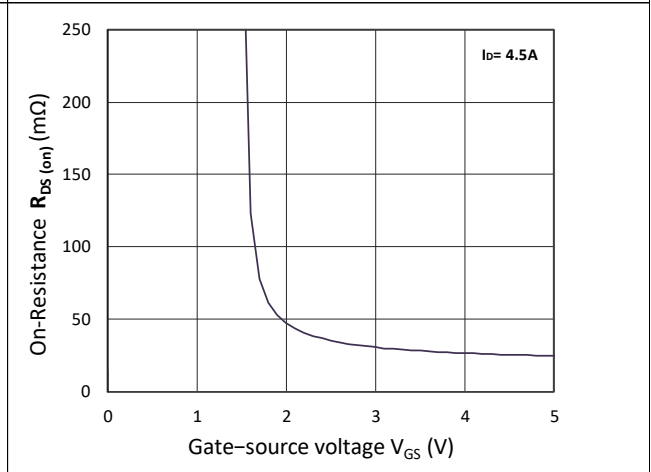


Figure 4. $R_{DS(on)}$ vs. V_{GS}

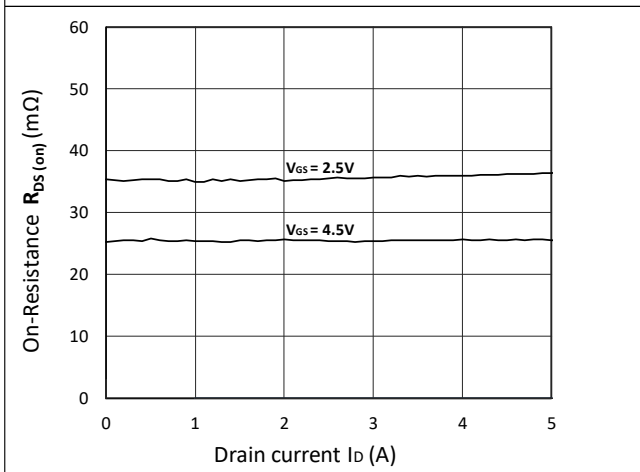


Figure 5. $R_{DS(on)}$ vs. I_D

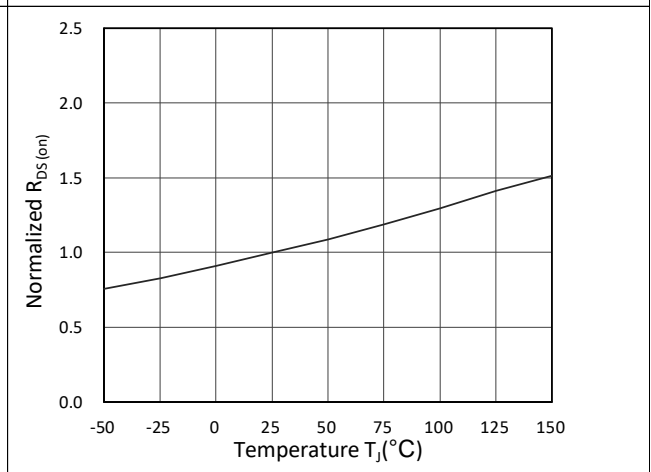


Figure 6. Normalized $R_{DS(on)}$ vs. Temperature

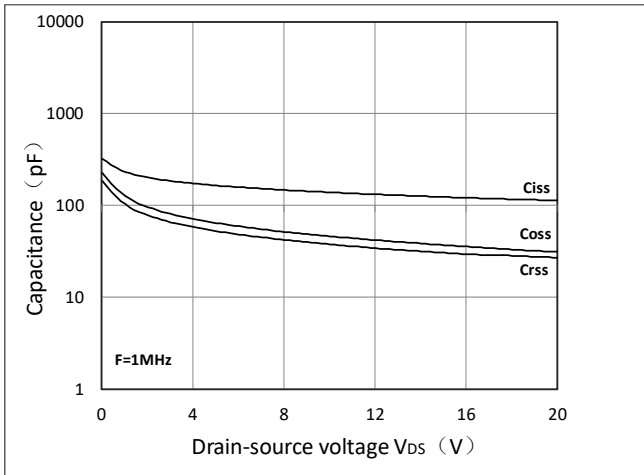


Figure 7. Capacitance Characteristics

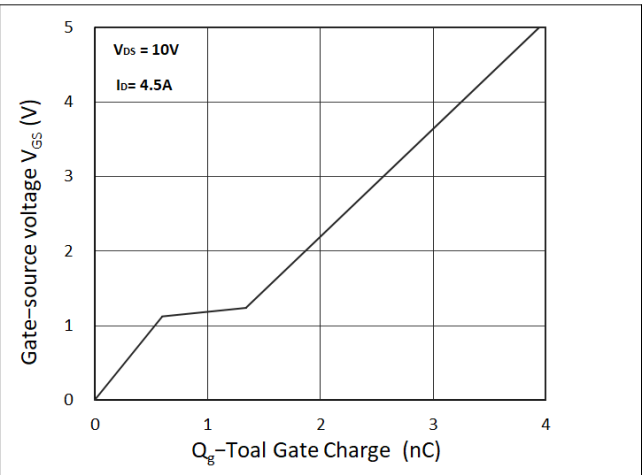


Figure 8. Gate Charge Characteristics

Typical Characteristics:P-CHANNEL

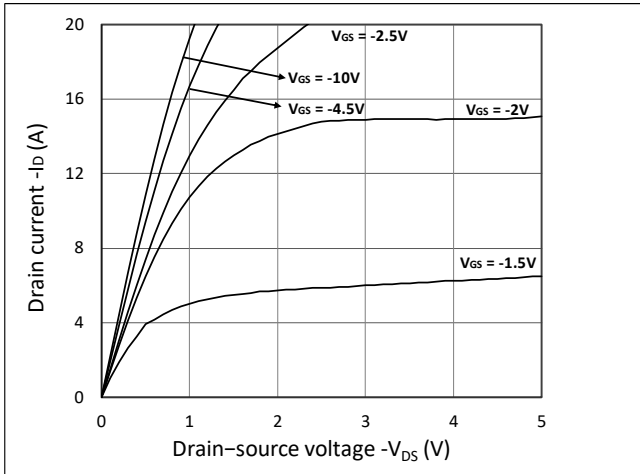


Figure 1. Output Characteristics

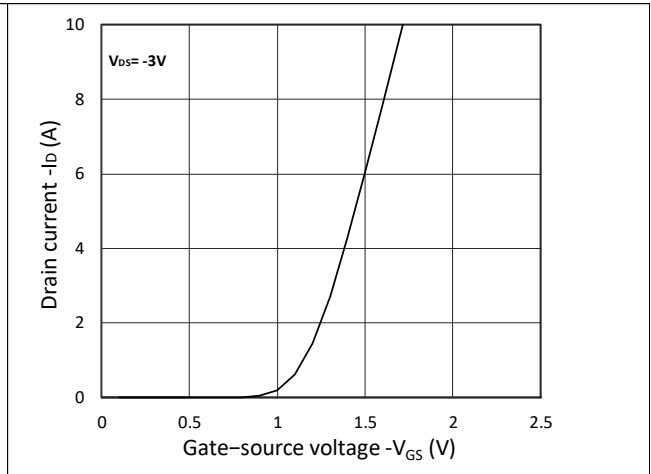


Figure 2. Transfer Characteristics

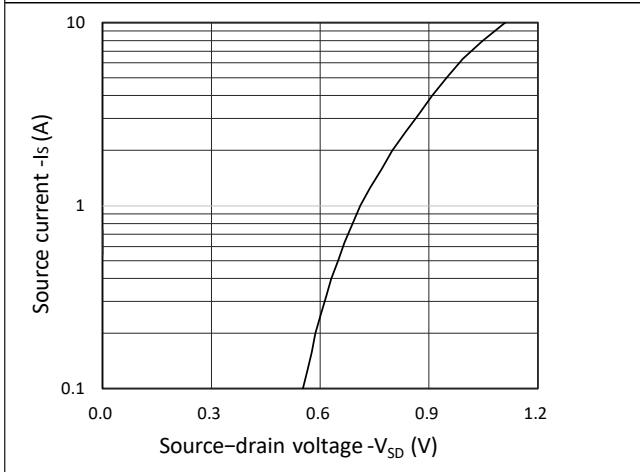


Figure 3. Forward Characteristics of Reverse

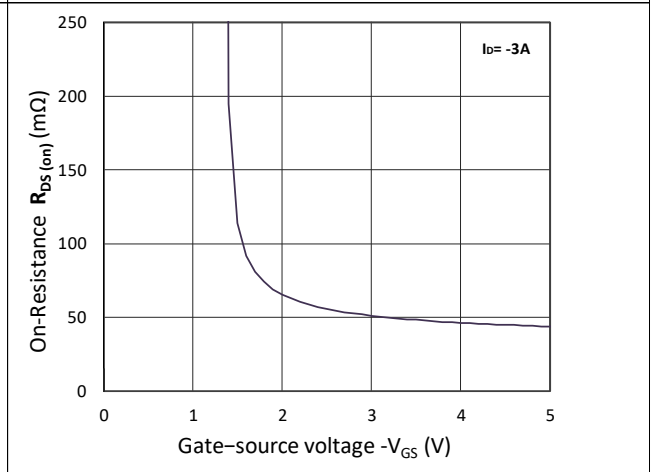


Figure 4. $R_{DS(ON)}$ vs. V_{GS}

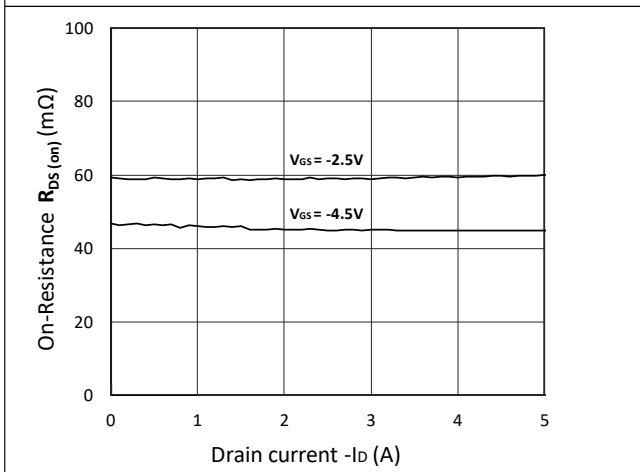


Figure 5. $R_{DS(ON)}$ vs. I_D

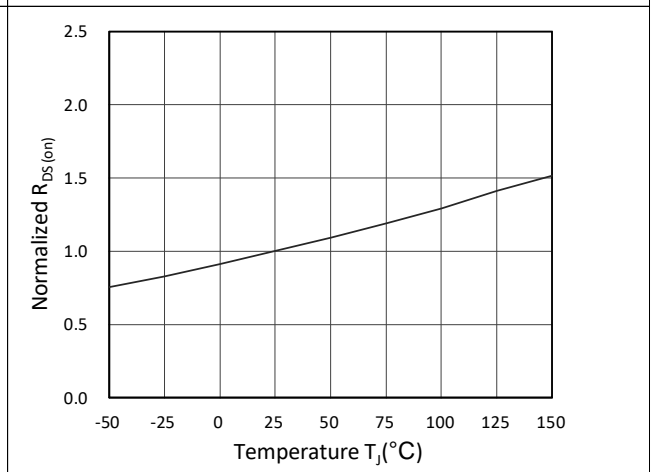


Figure 6. Normalized $R_{DS(ON)}$ vs. Temperature

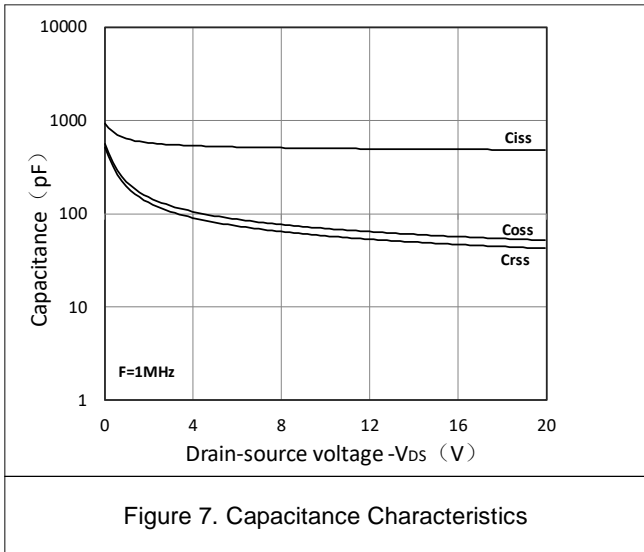


Figure 7. Capacitance Characteristics

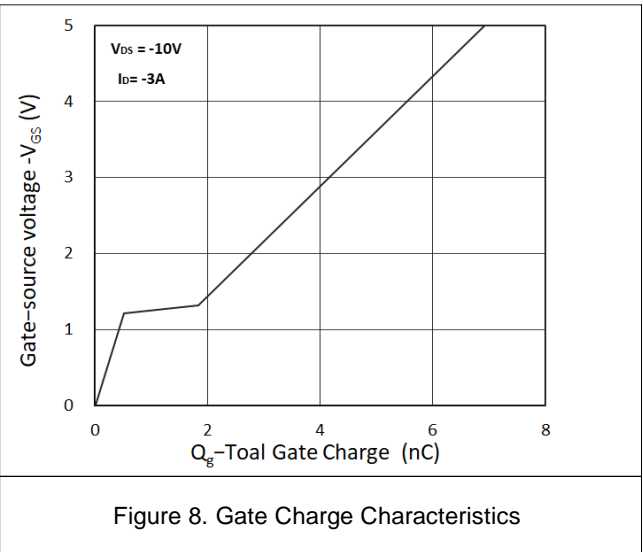
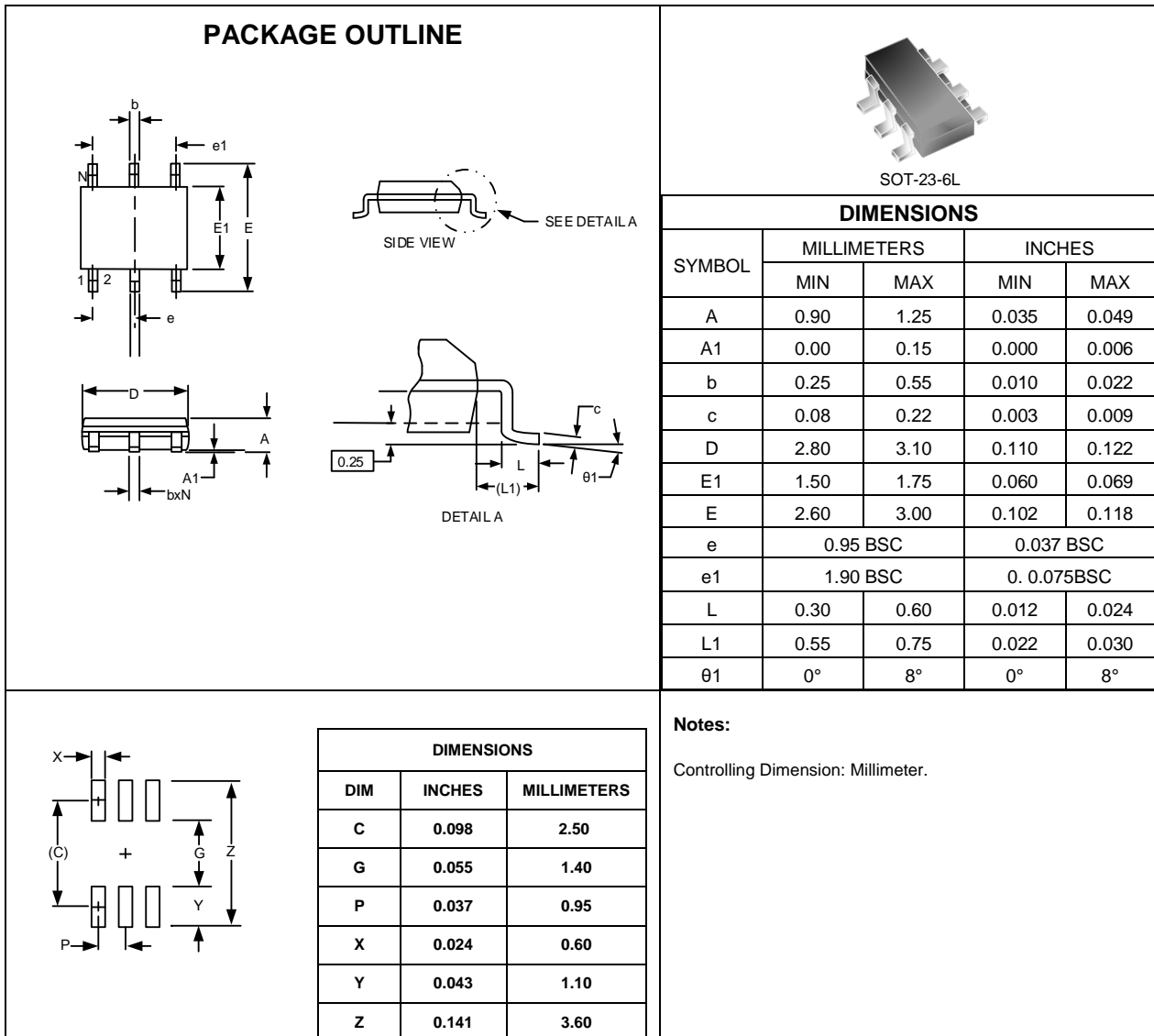


Figure 8. Gate Charge Characteristics

Outline Drawing – SOT-23-6L



Marking Codes

Part Number	WM02DH50M3
Marking Code	

Package Information

Qty: 3k/Reel

CONTACT INFORMATION

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For additional information, please contact your local Sales Representative.

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Specifications are subject to change without notice.

The device characteristics and parameters in this data sheet can and do vary in different applications and actual device performance may vary over time. Users should verify actual device performance in their specific applications.